

PATENT APPLICATION

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FORM PTO-1449	ATTY. DKT NO. 12-019	SER. NO. 10/050,103
APPLICANT TAKADA		
FILING DATE January 18, 2002	GROUP 1756	



REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS

FOREIGN PATENT DOCUMENTS

TRANSLATION

		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO
<i>al</i>		EP 0 828 202 A2	3/11/98	EUROPE				X	
<i>ew</i>		WO 96/34322	10/31/96	PCT				X	

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER	<i>John W.</i>	DATE CONSIDERED <i>1/15/04</i>

Rev. 10/94 (Form 3.05)

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
<i>leff</i>		6,111,670 (Corresponding to JP-A-11-102153)	Aug. 29, 2000	Hattori et al.	359	15

FOREIGN PATENT DOCUMENTS

TRANSLATION

		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO
<i>leff</i>		JP-A-11-102153 (Discussed on page 1 of the spec.)	4/13/99	JAPAN				X	

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER	DATE CONSIDERED	
<i>leff</i>	<i>1/15/04</i>	